

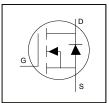
# Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Enhanced dV/dT and dI/dT capability
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

## Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.





| V <sub>DSS</sub>                 | 100V             |
|----------------------------------|------------------|
| R <sub>DS(on) typ.</sub>         | $3.7$ m $\Omega$ |
| max                              | 4.5m $Ω$         |
| I <sub>D (Silicon Limited)</sub> | 180A①            |
| I <sub>D (Package Limited)</sub> | 120A             |



| G    | D     | S      |
|------|-------|--------|
| Gate | Drain | Source |

| Base next number | Dookogo Tymo | Standard Pack |          | Orderable Dout Number |
|------------------|--------------|---------------|----------|-----------------------|
| Base part number | Package Type | Form          | Quantity | Orderable Part Number |
| AUIRFP4110       | TO-247AC     | Tube          | 25       | AUIRFP4110            |

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature  $(T_A)$  is 25°C, unless otherwise specified.

|                                         | Parameter                                                         | Max.                | Units |
|-----------------------------------------|-------------------------------------------------------------------|---------------------|-------|
| $I_D$ @ $T_C$ = 25°C                    | Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) | <b>180</b> ①        |       |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) | 130①                |       |
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited) | 120                 | A     |
| I <sub>DM</sub>                         | Pulsed Drain Current ②                                            | 670                 |       |
| P <sub>D</sub> @T <sub>C</sub> = 25°C   | Maximum Power Dissipation                                         | 370                 | W     |
|                                         | Linear Derating Factor                                            | 2.5                 | W/°C  |
| $V_{GS}$                                | Gate-to-Source Voltage                                            | ± 20                | V     |
| E <sub>AS (Thermally limited)</sub>     | Single Pulse Avalanche Energy ③                                   | 190                 | mJ    |
| I <sub>AR</sub>                         | Avalanche Current ②                                               | 108                 | Α     |
| E <sub>AR</sub>                         | Repetitive Avalanche Energy ©                                     | 37                  | mJ    |
| dv/dt                                   | Peak Diode Recovery 4                                             | 5.3                 | V/ns  |
| T <sub>J</sub><br>T <sub>STG</sub>      | Operating Junction and Storage Temperature Range                  | -55 to + 175        | °C    |
|                                         | Soldering Temperature, for 10 seconds (1.6mm from case)           | 300                 |       |
|                                         | Mounting Torque, 6-32 or M3 Screw                                 | 10 lbf·in (1.1 N·m) |       |

## **Thermal Resistance**

| THO THAT I TO GO TATIO |                                    |      |       |       |  |
|------------------------|------------------------------------|------|-------|-------|--|
|                        | Parameter                          | Тур. | Max.  | Units |  |
| $R_{\theta JC}$        | Junction-to-Case ®                 |      | 0.402 |       |  |
| $R_{\theta CS}$        | Case-to-Sink, Flat Greased Surface | 0.24 |       | °C/W  |  |
| $R_{\theta JA}$        | Junction-to-Ambient                |      | 40    |       |  |

HEXFET® is a registered trademark of Infineon.

<sup>\*</sup>Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

|                                   | Parameter                            | Min. | Тур.  | Max. | Units | Conditions                                         |
|-----------------------------------|--------------------------------------|------|-------|------|-------|----------------------------------------------------|
| $V_{(BR)DSS}$                     | Drain-to-Source Breakdown Voltage    | 100  |       |      | V     | $V_{GS} = 0V, I_D = 250\mu A$                      |
| $\Delta V_{(BR)DSS}/\Delta T_{J}$ | Breakdown Voltage Temp. Coefficient  |      | 0.108 |      | V/°C  | Reference to 25°C, I <sub>D</sub> = 5mA            |
| R <sub>DS(on)</sub>               | Static Drain-to-Source On-Resistance |      | 3.7   | 4.5  | mΩ    | V <sub>GS</sub> = 10V, I <sub>D</sub> = 75A ⑤      |
| $V_{GS(th)}$                      | Gate Threshold Voltage               | 2.0  |       | 4.0  | V     | $V_{DS} = V_{GS}$ , $I_D = 250\mu A$               |
| gfs                               | Forward Trans conductance            | 160  |       |      | S     | $V_{DS} = 50V, I_{D} = 75A$                        |
|                                   | Durain to Course Lookens Course      |      |       | 20   |       | V <sub>DS</sub> =100 V, V <sub>GS</sub> = 0V       |
| I <sub>DSS</sub>                  | Drain-to-Source Leakage Current      |      |       | 250  | μA    | $V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$ |
|                                   | Gate-to-Source Forward Leakage       |      |       | 100  | nA    | V <sub>GS</sub> = 20V                              |
| I <sub>GSS</sub>                  | Gate-to-Source Reverse Leakage       |      |       | -100 | IIA   | V <sub>GS</sub> = -20V                             |
| $R_G$                             | Gate Resistance                      |      | 1.3   |      | Ω     |                                                    |

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

| •                         | <b>O</b> ,                                    | •        |     | ,  |                                                    |
|---------------------------|-----------------------------------------------|----------|-----|----|----------------------------------------------------|
| $Q_g$                     | Total Gate Charge                             | <br>150  | 210 |    | I <sub>D</sub> = 75A                               |
| $Q_{gs}$                  | Gate-to-Source Charge                         | <br>35   |     | nC | V <sub>DS</sub> = 50V                              |
| $Q_{gd}$                  | Gate-to-Drain Charge                          | <br>43   |     |    | V <sub>GS</sub> = 10V⑤                             |
| $t_{d(on)}$               | Turn-On Delay Time                            | <br>25   |     |    | $V_{DD} = 65V$                                     |
| t <sub>r</sub>            | Rise Time                                     | <br>67   |     |    | I <sub>D</sub> = 75A                               |
| $t_{d(off)}$              | Turn-Off Delay Time                           | <br>78   |     | ns | $R_G = 2.6\Omega$                                  |
| $t_f$                     | Fall Time                                     | <br>88   |     |    | V <sub>GS</sub> = 10V⑤                             |
| C <sub>iss</sub>          | Input Capacitance                             | <br>9620 |     |    | $V_{GS} = 0V$                                      |
| C <sub>oss</sub>          | Output Capacitance                            | <br>670  |     |    | $V_{DS} = 50V$                                     |
| $C_{rss}$                 | Reverse Transfer Capacitance                  | <br>250  |     | pF | f = 1.0MHz                                         |
| C <sub>oss eff.(ER)</sub> | Effective Output Capacitance (Energy Related) | <br>820  |     |    | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 80V⑦ |
| Coss eff.(TR)             | Output Capacitance (Time Related)             | <br>950  |     |    | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$         |

### **Diode Characteristics**

|                  | Parameter                              | Min. | Тур. | Max. | Units | Conditions                                     |
|------------------|----------------------------------------|------|------|------|-------|------------------------------------------------|
| Is               | Continuous Source Current (Body Diode) |      |      | 180① |       | MOSFET symbol showing the                      |
| I <sub>SM</sub>  | Pulsed Source Current (Body Diode) ②   |      |      | 670  |       | integral reverse p-n junction diode.           |
| $V_{SD}$         | Diode Forward Voltage                  |      |      | 1.3  | ٧     | $T_J = 25^{\circ}C, I_S = 75A, V_{GS} = 0V $ § |
| 4                | Reverse Recovery Time                  |      | 50   | 75   | 200   | $T_{J} = 25^{\circ}C$ $V_{DD} = 85V$           |
| t <sub>rr</sub>  | Reverse Recovery Time                  |      | 60   | 90   | ns    | $T_J = 125^{\circ}C$ $I_F = 75A$ ,             |
| 0                | Daviera Dasaver Charge                 |      | 94   | 140  | 5     | $T_J = 25^{\circ}C$ di/dt = 100A/µs ©          |
| $Q_{rr}$         | Reverse Recovery Charge                |      | 140  | 210  | nC    | <u>T<sub>J</sub> = 125°C</u>                   |
| I <sub>RRM</sub> | Reverse Recovery Current               |      | 3.5  |      | Α     | $T_J = 25^{\circ}C$                            |

#### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 120A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by  $T_{Jmax}$ , starting  $T_J = 25$ °C, L = 0.033mH,  $R_G = 25\Omega$ ,  $I_{AS} = 108$ A,  $V_{GS} = 10$ V. Part not recommended for use above this value.
- S Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- ©  $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- © Coss eff. (ER) is a fixed capacitance that gives the same energy as Coss while VDS is rising from 0 to 80% VDSS.
- $^{\circ}$  R<sub>0</sub> is measured at TJ approximately 90°C.



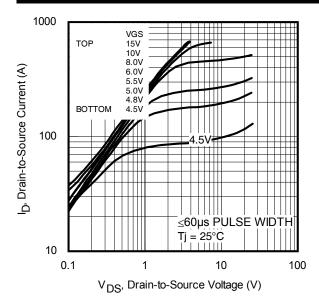


Fig 1. Typical Output Characteristics

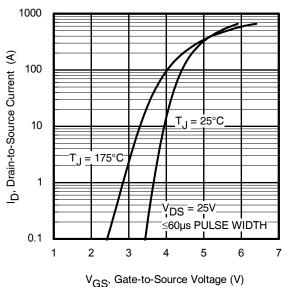


Fig 3. Typical Transfer Characteristics

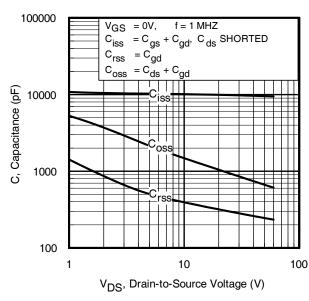


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

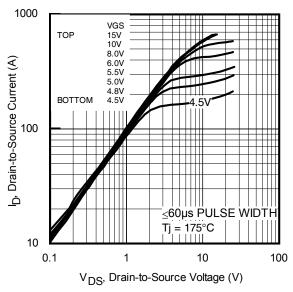


Fig 2. Typical Output Characteristics

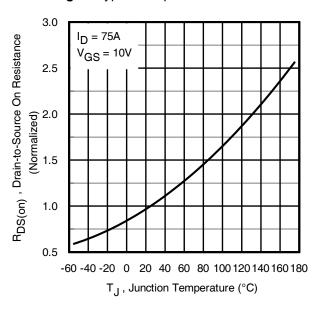


Fig 4. Normalized On-Resistance vs. Temperature

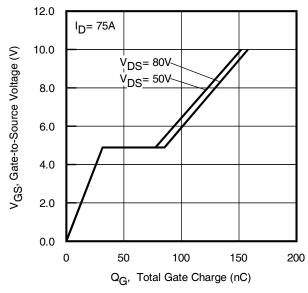


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

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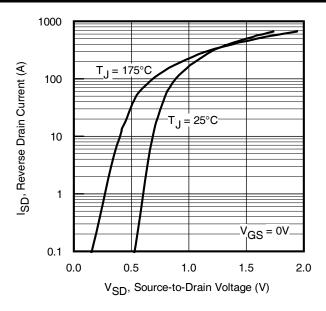


Fig 7. Typical Source-Drain Diode Forward Voltage

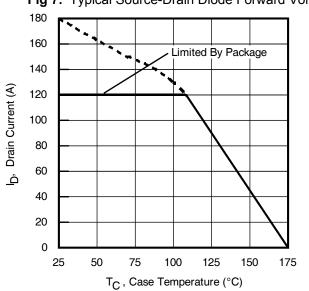


Fig 9. Maximum Drain Current vs. Case Temperature

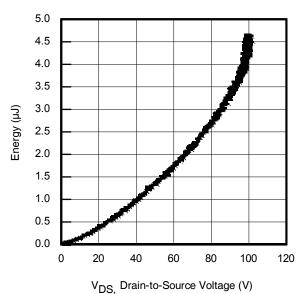


Fig 11. Typical Coss Stored Energy

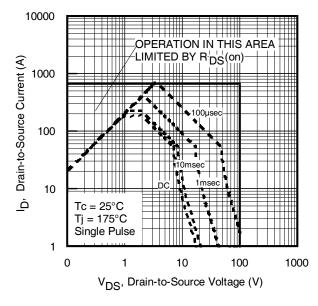


Fig 8. Maximum Safe Operating Area

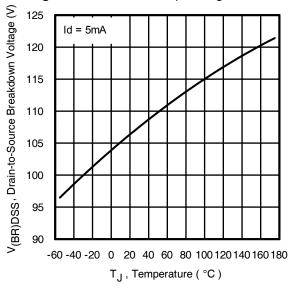


Fig 10. Drain-to-Source Breakdown Voltage

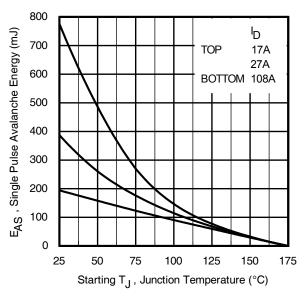


Fig 12. Threshold Voltage vs. Temperature

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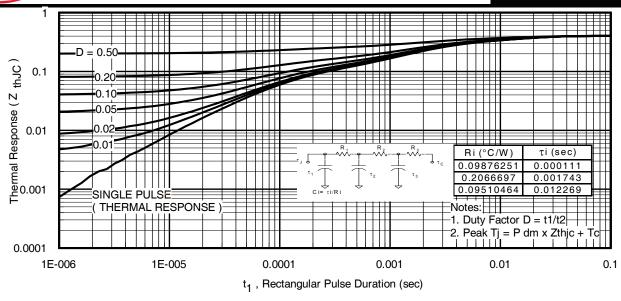


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

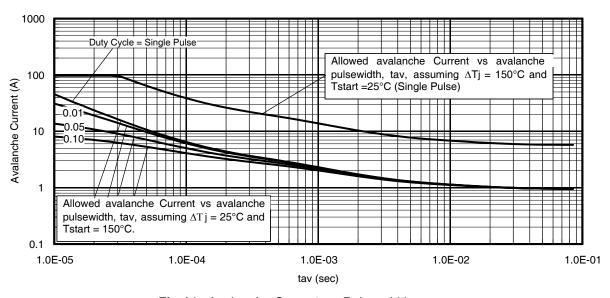


Fig 14. Avalanche Current vs. Pulse width

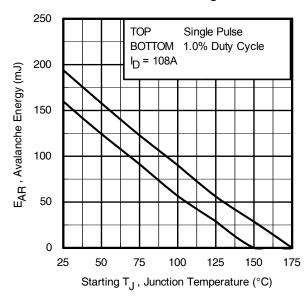


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of Timax. This is validated for every part type.
- Safe operation in Avalanche is allowed as long asTjmax is not avacaded.
- exceeded.

  3. Equation below based on circuit and waveforms shown in Figures
- 22a,22b.
  4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not exceed  $T_{jmax}$  (assumed as 25°C in figure 14 , 15). tav = Average time in avalanche. D = Duty cycle in avalanche = tav ·f

ZthJC (Ď, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ ( } 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \Delta \text{T} / \text{ Z}_{thJC} \\ I_{av} &= 2\Delta \text{T} / \text{ [ } 1.3 \cdot \text{BV} \cdot \text{Z}_{th} \text{]} \\ E_{AS \text{ (AR)}} &= PD_{\text{ (ave)}} \cdot t_{av} \end{split}$$



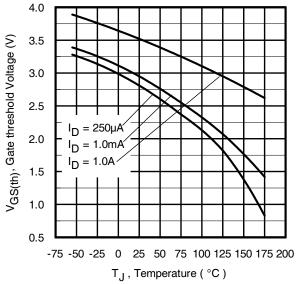


Fig 16. Threshold Voltage vs. Temperature

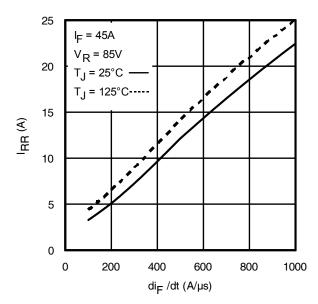
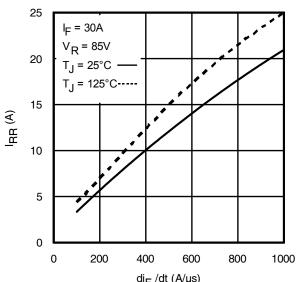


Fig 18. Typical Recovery Current vs. dif/dt



 $di_F$  /dt (A/ $\mu$ s) Fig 17. Typical Recovery Current vs. dif/dt

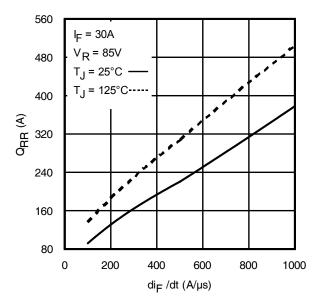


Fig 19. Typical Stored Charge vs. dif/dt

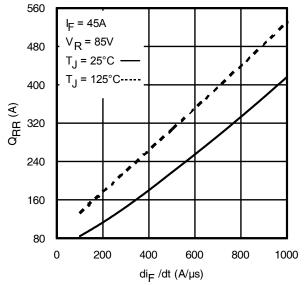


Fig 20. Typical Stored Charge vs. dif/dt



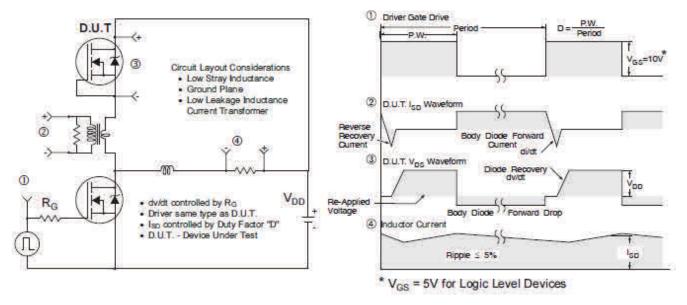


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

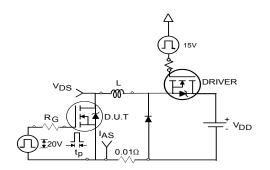


Fig 22a. Unclamped Inductive Test Circuit

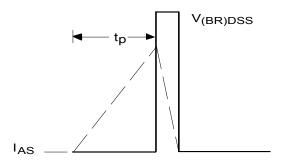


Fig 22b. Unclamped Inductive Waveforms

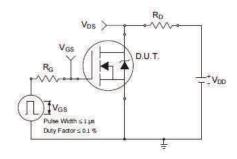


Fig 23a. Switching Time Test Circuit

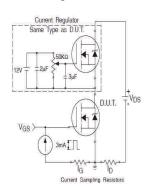


Fig 24a. Gate Charge Test Circuit

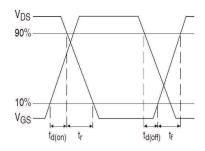


Fig 23b. Switching Time Waveforms

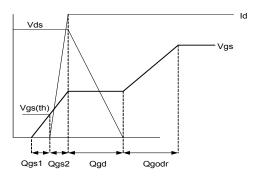


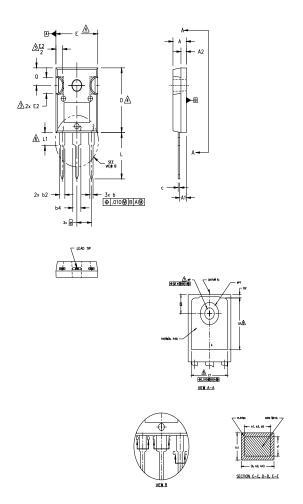
Fig 24b. Gate Charge Waveform

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# TO-247AC Package Outline

Dimensions are shown in millimeters (inches)



#### NOTES:

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
- 2. DIMENSIONS ARE SHOWN IN INCHES.
- 3. CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

6. LEAD FINISH UNCONTROLLED IN L1.

#P TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 \* TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

 \*\*TOP TO THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.\*\*

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8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

|        |      | DIMEN | ISIONS |             |       |           |
|--------|------|-------|--------|-------------|-------|-----------|
| SYMBOL | INC  | HES   | MILLIM | MILLIMETERS |       |           |
|        | MIN. | MAX.  | MIN.   | MAX.        | NOTES |           |
| A      | .183 | .209  | 4.65   | 5.31        |       | 1         |
| A1     | .087 | .102  | 2.21   | 2.59        |       |           |
| A2     | .059 | .098  | 1.50   | 2.49        |       |           |
| b      | .039 | .055  | 0.99   | 1.40        |       |           |
| ь1     | .039 | .053  | 0.99   | 1.35        |       | LEAD      |
| b2     | .065 | .094  | 1.65   | 2.39        |       |           |
| b3     | .065 | .092  | 1.65   | 2.34        |       |           |
| b4     | .102 | .135  | 2.59   | 3.43        |       |           |
| b5     | .102 | .133  | 2.59   | 3.38        |       |           |
| С      | .015 | .035  | 0.38   | 0.89        |       |           |
| c1     | .015 | .033  | 0.38   | 0.84        |       |           |
| D      | .776 | .815  | 19.71  | 20.70       | 4     |           |
| D1     | .515 | -     | 13.08  | -           | 5     |           |
| D2     | .020 | .053  | 0.51   | 1.35        |       |           |
| E      | .602 | .625  | 15.29  | 15.87       | 4     | <u>IG</u> |
| E1     | .530 | -     | 13.46  | -           |       |           |
| E2     | .178 | .216  | 4.52   | 5.49        |       |           |
| e      | .215 | BSC   | 5.46   | BSC         | 1     |           |
| Øk     | .0   | 10    | 0.     | 25          |       |           |
| L      | .559 | .634  | 14.20  | 16.10       |       |           |
| L1     | .146 | .169  | 3.71   | 4.29        |       |           |
| ØΡ     | .140 | .144  | 3.56   | 3.66        |       |           |
| øP1    | -    | .291  | -      | 7.39        |       |           |
| Q      | .209 | .224  | 5.31   | 5,69        |       |           |
| S      | .217 | BSC   | 5.51   | BSC         |       |           |
|        |      |       | 1      |             | 1     | 1         |

### LEAD ASSIGNMENTS

# HEXFET

- 1.- GATE 2.- DRAIN
- 3.- SOURCE 4.- DRAIN

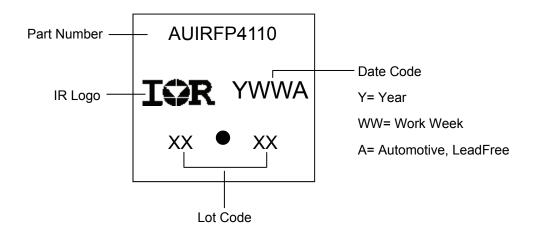
### IGBTs, CoPACK

- 1.- GATE 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR
- 4.- COLLECT

### <u>DIODES</u>

1.- ANODE/OPEN 2.- CATHODE 3.- ANODE

# **TO-247AC Part Marking Information**



TO-247AC package is not recommended for Surface Mount Application.



#### **Qualification Information**

| Qualification        | IIIIOIIIIatioii                     |                                  |                                                                                                                                                                               |  |  |  |  |  |
|----------------------|-------------------------------------|----------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|--|--|--|--|
|                      |                                     |                                  | Automotive                                                                                                                                                                    |  |  |  |  |  |
|                      |                                     |                                  | (per AEC-Q101)                                                                                                                                                                |  |  |  |  |  |
| Qualification        | Level                               | Infineon's Inc                   | Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. |  |  |  |  |  |
| Moisture Sen         | ture Sensitivity Level TO-247AC N/A |                                  |                                                                                                                                                                               |  |  |  |  |  |
| Machine Model        |                                     |                                  | Class M4 (+/- 800) <sup>†</sup>                                                                                                                                               |  |  |  |  |  |
|                      |                                     |                                  | AEC-Q101-002                                                                                                                                                                  |  |  |  |  |  |
| ECD                  | Human Body Model                    |                                  | Class H3A (+/- 6000V) <sup>†</sup>                                                                                                                                            |  |  |  |  |  |
| ESD                  |                                     | AEC-Q101-001                     |                                                                                                                                                                               |  |  |  |  |  |
| Charged Device Model |                                     | Class C5 (+/- 2000) <sup>†</sup> |                                                                                                                                                                               |  |  |  |  |  |
|                      |                                     |                                  | AEC-Q101-005                                                                                                                                                                  |  |  |  |  |  |
| RoHS Compli          | ant                                 | Yes                              |                                                                                                                                                                               |  |  |  |  |  |

<sup>†</sup> Highest passing voltage.

### **Revision History**

| Date      | Comments                                        |  |  |  |  |
|-----------|-------------------------------------------------|--|--|--|--|
| 9/15/2017 | Updated datasheet with corporate template       |  |  |  |  |
| 9/13/2017 | Corrected typo error on part marking on page 8. |  |  |  |  |

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